YF INTERNATIONAL LIMITED

RECIPIENT

SPECIFICATIONS

| Product No. : | X1E000021035200 |
|---------------|-----------------|
|---------------|-----------------|

| MODEL : | TSX-3225 |
|---------|-----------------|
|---------|-----------------|

SPEC. No. : A12-1007-1B

DATE: Mar. 27. 2013

SEIKO EPSON CORPORATION

8548 Naka-minowa Minowa-machi Kamiina-gun Nagano-ken 399-4696 Japan

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SPECIFICATIONS

1. Application

This document is applicable to the crystal unit that are delivered to YF INTERNATIONAL LIMITED from Seiko Epson Corp.

This product complies with RoHS Directive.

This Product supplied (and any technical information furnished, if any) by Seiko Epson Corporation shall not be used for the development and manufacture of weapon of mass destruction or for other military purposes. Making available such products and technology to any third party who may use such products or technologies for the said purposes are also prohibited.

This product listed here is designed as components or parts for electronics equipment in general consumer use. We do not expect that any of these products would be incorporated or otherwise used as a component or part for the equipment, which requires an extra high reliability, such as satellite, rocket and other space systems, and medical equipment, the functional purpose of which is to keep life.

2. Product No. / Model

The product No. of this crystal unit is X1E000021035200. The model is TSX-3225.

3. Packing

It is subject to the packing standard of Seiko Epson Corp.

4. Warranty

Defective parts which originate with us are replaced free of charge in the case of defects being found with 12 months after delivery.

5. Amendment and/or termination

Amendment and/or termination of this specification are subject to the agreement between the two parties.

6. Contents

| Item No. | Item | Page |
|----------|---|------|
| [1] | Absolute maximum ratings | 2 |
| [2] | Operating range | 2 |
| [3] | Electrical characteristics | 2 |
| [4] | Environmental and mechanical characteristics | 3 |
| [5] | Dimensions and circuit | 4 |
| [6] | Recommended soldering pattern and marking layout | 5 |
| [7] | Notes | 6 |

7. MSL

MSL level 1

[1] Absolute maximum ratings

| ۰J | 110001000 1110011111 | | 0° | |
|----|---------------------------|--------|-------------------|--|
| | Parameter | Symbol | Rating value | Note |
| | Storage temperature range | T_stg | -40 °C to +125 °C | Frequency aging depends on the environmental characteristic specification. |

[2] Operating range

| D | G 1 1 | Value | | •, | | |
|--------------------------------|--------|-------|------|------|------|--|
| Parameter | Symbol | Min. | Тур. | Max. | unit | Note |
| Operating temperature range | T_use | -40 | | +85 | °C | Frequency aging depends on the Environmental characteristic specification. |
| Level of drive | DL | - | 10 | 200 | μW | Recommended Level of drive (1 to 100 µW) |

[3] Electrical characteristics

| Parameter | Symbol | Standard | Conditions |
|--|--------|----------------------------------|---|
| Nominal frequency | f | 25 MHz | Fundamental |
| Frequency tolerance | f_tol | $\pm 10 	imes 10^{-6}$ | CL = 20 pF $T_{use} = +25 \text{ °C} \pm 3 \text{ °C}$ Level of drive : 10 μ W. π circuit Not include aging. |
| Frequency versus temperature characteristics | f_tem | $\pm 18 \times 10^{-6}$ | Ta = -40 °C to +85 °C (Ref. at + 25 °C \pm 3 °C) Level of drive : 100 μ W Series resonance. |
| Motional resistance(ESR) | R_1 | 40 Ω Max. | π circuit (IEC60444-2) |
| Insulation resistance | IR | 500 MΩ Min. | DC 100 V±15 V 60 sec. |
| Frequency aging | f_age | \pm 1 × 10 ⁻⁶ /year | $T_{use} = +25 \text{ °C} \pm 3 \text{ °C}(\text{no bias})$ |

[4] Environmental and mechanical characteristics

| No. | Item | Value *1 *2 | Test Conditions |
|------|------------------------------|---|--|
| 110. | Itelli | $\Delta f / f [1 \times 10^{-6}]$ | Test Conditions |
| 1 | Drop | *3 ± 2.0 | 100 g dummy Jig (SE Standard) drop |
| | | | from 1500 mm height on the concrete 3 |
| | | | directions 10 times |
| 2 | Vibration | *3 ± 1.0 | 10 Hz to 55 Hz amplitude 0.75 mm |
| | | | 55 Hz to 500 Hz acceleration 98 m/s^2 |
| | | | $10 \text{ Hz} \rightarrow 500 \text{ Hz} \rightarrow 10 \text{ Hz} 15 \text{ min./cycle}$ |
| | | | 6 h (2 hours , 3 directions) |
| 3 | High temperature storage | *3 ± 2.0 | +85 °C × 1 000 h |
| 4 | Low temperature storage | *3 ± 2.0 | -40 °C × 1 000 h |
| 5 | Temperature humidity | *3 ± 2.0 | +85 °C × 85 %RH × 1 000 h |
| | storage | | |
| 6 | Temperature cycle | *3 ± 2.0 | $-40 \circ C \leftrightarrow +85 \circ C$ |
| | | | 30 minutes at each temp. 1 000 cycle |
| 7 | Sealing | *3 $1 \times 10^{-9} \text{ Pa} \cdot \text{m}^3/\text{s Max}.$ | For He leak detector |
| 8 | Shear | No peeling-off at a solder | 10 N press for 10 s \pm 1 s |
| | | part | Ref. IEC 60068-2-21 |
| 9 | Pull – off | No peeling-off at a solder | 10 N press for 10 s \pm 1 s |
| | | part | Ref. IEC 60068-2-21 |
| 10 | Solderability | Terminals must be 95% | Dip termination into solder bath at |
| | | covered | $+235 \text{ °C} \pm 5 \text{ °C}$ for 5 s |
| | | With fresh solder. | (Using Rosin Flux) |
| 11 | Resistance to soldering heat | ± 1.0 | For convention reflow soldering furnace |
| | | | (3 times)(For IPC/JEDEC J-STD-020C) |

(The company evaluation condition : We evaluate it by the following examination item and examination condition.)

< Notes >

1. *1 each test done independently.

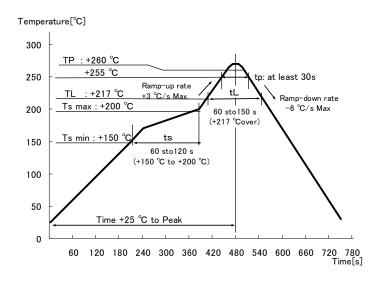
2. *2 measuring 24 h later leaving in room temperature after each test.

3. *3 Item No.1 to No.7shall be tested after following pre conditioning.

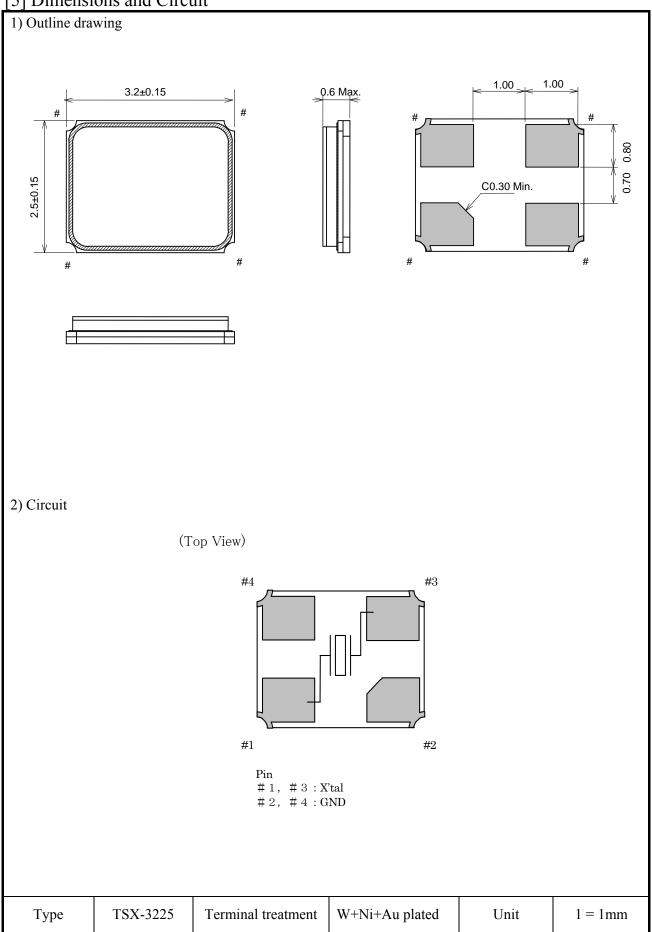
4. Resistance at before above tests should be less than ± 20 % or less than $\pm 10 \Omega$.

5. Pre conditioning : Test crystal must be leaving in room temperature for 24 h after reflow(3 times).

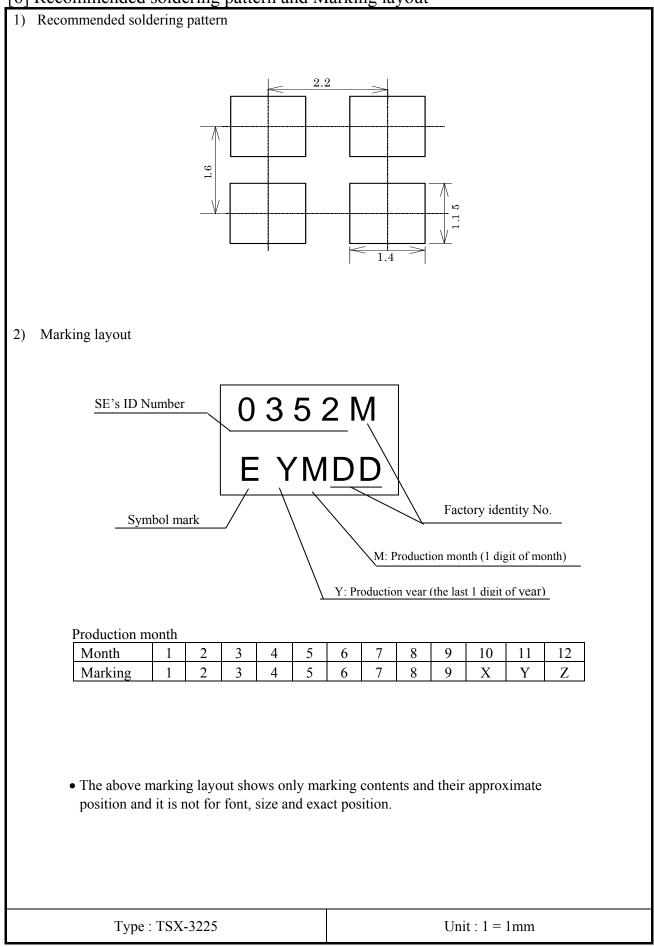
Convention reflow (follow to IPC / JEDEC J-STD-020D.1)



[5] Dimensions and Circuit



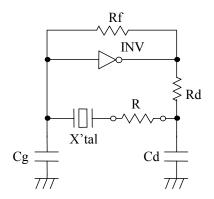
[6] Recommended soldering pattern and Marking layout



[7] Notes

- Max three (3) times reflow is allowed.
 I hope the gauntlet ahead in 5s or less from +350 °C or less in case of the adjustment with the soldering iron.
- 2. Too much exciting shock or vibration may cause deterioration on damage. Depending on the condition such as a shock in assembly machinery, the products may be damaged. Please check your condition in advance to maintain shock level to be smallest.
- 3. The shortest line patterning on board is recommendable. Too long line on board may cause of abnormal oscillation.
- Please normal temperature (+15 °C to +35 °C) and normal humidity (25 to 85 %RH) as much as possible for the frequency accuracy securing. Storing the crystal products under higher or lower temperature or high humidity for long period may affect frequency stability or solderability. Check conditions prior to use.
- 5. This product may be affected to ultrasonic cleaning. Check conditions prior to use.
- 6. When do the be dewy of the oscillation circuit board, the frequency change or the oscillation stop is generated. Please use it under the condition without the be dewy.
- 7. Applying excessive excitation force to the crystal unit may cause deterioration damage.
- 8. Few data or readings taken at user side may be different from our company's data. Confirmation of the different value is necessary before application.
- 9. To avoid malfunction, no pattern under or near the crystal is allowed.
- 10. Unless adequate negative resistance is allocated in the oscillation circuit, start up time of oscillation may be increased, or no oscillation may occur. In order to avoid this, please provide enough negative resistance in the circuit design.

<How to check the negative resistance>



1) Connect the resister(R) to the circuit in series with the crystal unit.

- 2) Adjust R so that oscillation can start (or stop).
 Negative resistance of circuit (-R) =
 R+ Series resistance of crystal (R1)
- 3) Measure R when oscillation just start (or stop) in above(2) R> R1 Max. 5 to 10 times.

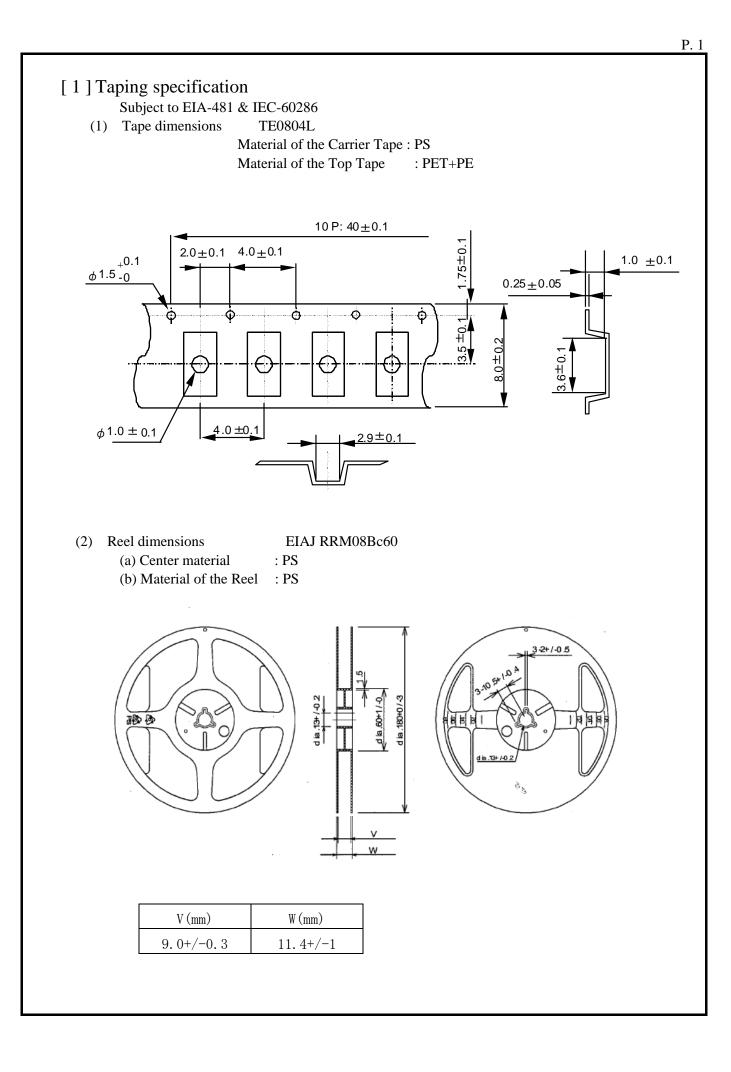
TAPING SPECIFICATION

1. APPLICATION

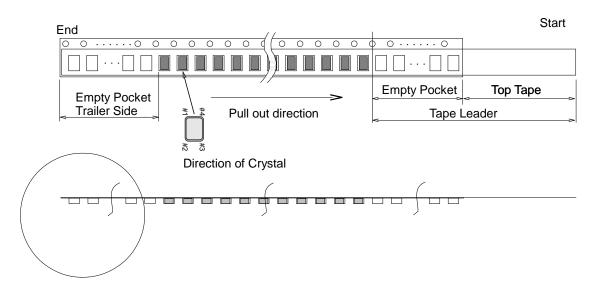
This document is applicable to TSX-3225

2. CONTENTS

| Item No. | Item | Page |
|----------|----------------------|--------|
| [1] | Taping specification | 1 to 2 |
| [2] | Inner carton | 3 |
| [3] | Shipping carton | 3 |
| [4] | Marking | |
| [5] | Quantity | 4 |
| [6] | Storage environment | 4 |
| [7] | Handling | |

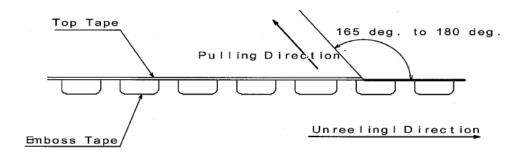


(3) Packing



| It | Empty Space | |
|--------------|---------------------|-------------|
| Tape Leader | Tape LeaderTop Tape | |
| | Carrier Tape | Min. 150 mm |
| Tape Trailer | Тор Таре | Min. 0 mm |
| | Carrier Tape | Min. 160 mm |

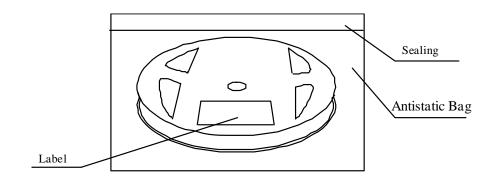
(4) Peel force of the cover tape



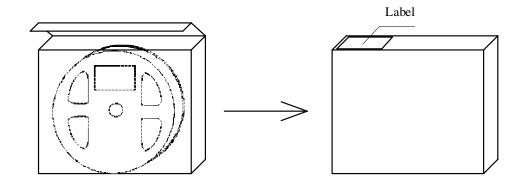
- (a) angle : cover tape during peel off and the direction of unreeling shall be 165° to 180° .
- (b) peel speed : 300 mm / min.
- (c) strength : 0.1 to 1 N.

[2] Inner Carton

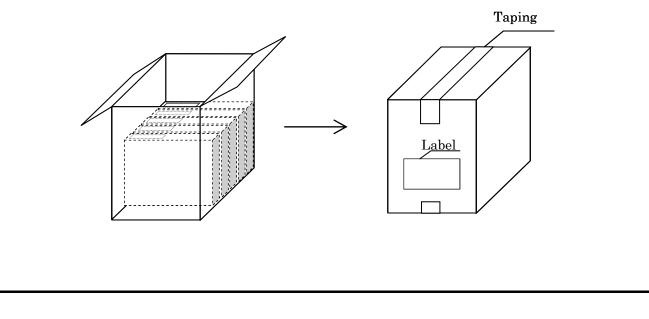
a) Packing to antistatic bag



b) Packing to inner carton



[3] Shipping Carton



[4] Marking

- (1) Reel marking
 - Reel marking shall consist of :
 - 1) Parts name
 - 2) Quantity
 - 3) Manufacturing Date or symbol
 - 4) Manufacturer's Date or symbol
 - 5) Others (if necessary)
- (2) Inner carton marking
 - Same as Reel marking.
- (3) Shipping carton marking
 - Shipping carton marking shall consist of :
 - 1) Parts name
 - 2) Quantity

[5] Quantity

• 2 000 pcs./reel

[6] Storage environment

- (1) Before open the packing, we recommend to keep less than +30 °C and 85 %RH of Humidity, and to use it less than 6 months after delivery.
- (2) We recommend to open Package in immediately before use. After open Package, We recommend to keeps less than 6 month. No need dry air before soldering work if it is less than temperature +30 °C, 85 humidity %RH.
- (3) Not to expose the sun.
- (4) Not to storage with some erosive chemicals.
- (5) Nothing is allowed to put on the reel or carton to prevent mechanical damage.

[7] Handling

To handle with care to prevent the damage of tape, reel and products.

- PROCESS QUALITY CONTROL -

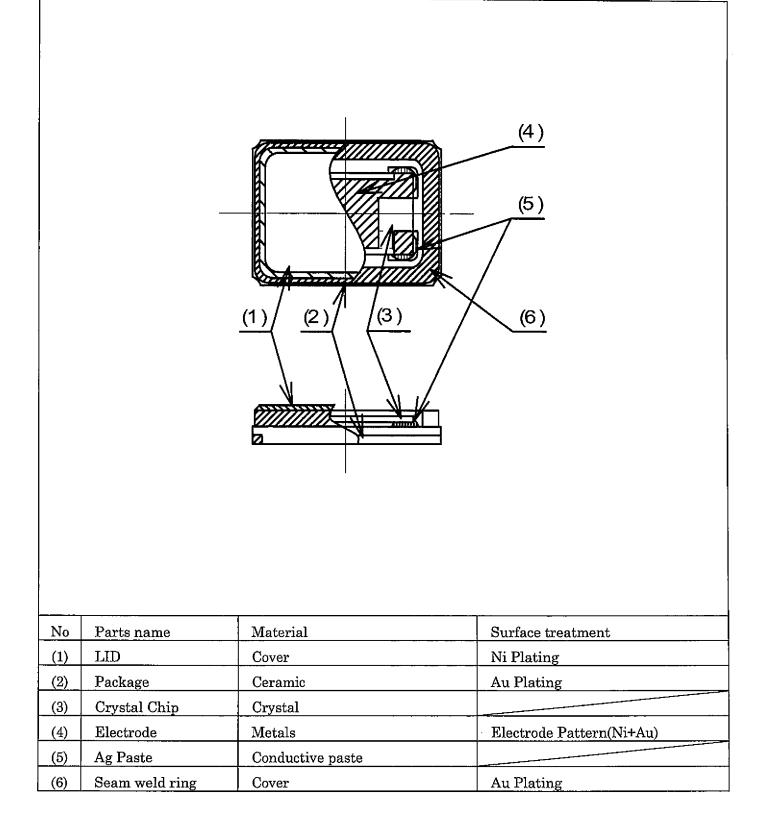
No.IA-0602-02-AAE-3 SND TYPE AT STRIP CRYSTAL TSX-3225

2012.09.14

| Manufacturing process chart | N 0. | Section | Standar ds | Inspection, Control Items | Inspection Methods | Instrument | Record |
|-----------------------------|------|---------------------------------|---------------------------------|---------------------------|--------------------|----------------------|----------------------|
| | 1 | Production Section | Manufacturing Instruction Sheet | Frequency | Sampling | Blank Oscillator | Process Data Sheet |
| ramic Base | | (Malaysia Plant/Thailand Plant) | | Outer Appearance | п | Microscope | |
| 7 | 2 | Production Section | н | Outer Appearance | Sampling | Microscope | н |
| | | (Malaysia Plant/Thailand Plant) | | | | | |
| In-coming | 3 | Production Section | п | Frequency | Sampling | Frequency Counter | н |
| Inspection ① Deposition | | (Malaysia Plant/Thailand Plant) | | | | | |
| <u> </u> | 4 | Production Section | " | Outer Appearance | Sampling | Microscope | 11 |
| Lid ② Mounting | | (Malaysia Plant/Thailand Plant) | | | | | |
| 7 I | 5 | Production Section | п | Package Leak | 100% Inspection | Leak Tester | 11 |
| In-coming ③ Frequency | | (Malaysia Plant/Thailand Plant) | | | | | |
| Dispection Adjustment | 6 | Production Section | п | Outer Appearance | Sampling | Microscope | н |
| <u> </u> | | (Malaysia Plant/Thailand Plant) | | | | | |
| ④ Welding | 7 | Production Section | " | Crystal Impedance | 100% Inspection | Inspection M/C | 11 |
| | | (Malaysia Plant/Thailand Plant) | | Frequency | " | | |
| 5 Leak Test | | | | Insulation Resistance | " | | |
| Ì | | | | Temp. Characteristic | " | 11 | |
| 6 Marking | | | | | | | |
| | 8 | Inspection Section | Out-going Inspection Standard | Crystal Impedance | Sampling | Inspection M/C | Out-going Inspection |
| Characteristic | | (Malaysia Plant/Thailand Plant) | | Frequency | п | 11 | Data Sheet |
| Inspection | | | | Outer Appearance | " | Microscope | |
| 🛞 Out-going Inspec | tion | | | | | | |
| | 9 | Production Section | Manufacturing Instruction Sheet | Tape-Peel Strength | Sampling | Peeling Force Tester | Process Data Sheet |
| (9) Taping | | (Malaysia Plant/Thailand Plant) | | | | | |
| | 10 | Production Control Section | Manufacturing Instruction Sheet | Destination | | | Delivery Slip |
| 10 Packing | | (Malaysia Plant/Thailand Plant) | Packing Instruction Sheet | Quantity | - | - | |
| | | | | | | | |
| | | | | | | | |

TSX-3225 Construction Drawing

No.: A-0602-AE-1



RELIABILITY TEST DATA Product Name : TSX-3225 (16MHz ≤ f0 < 40MHz)

The Company evaluation condition

We evaluate environmental and mechanical characteristics by the following test condition . No. A-06021-01-004E

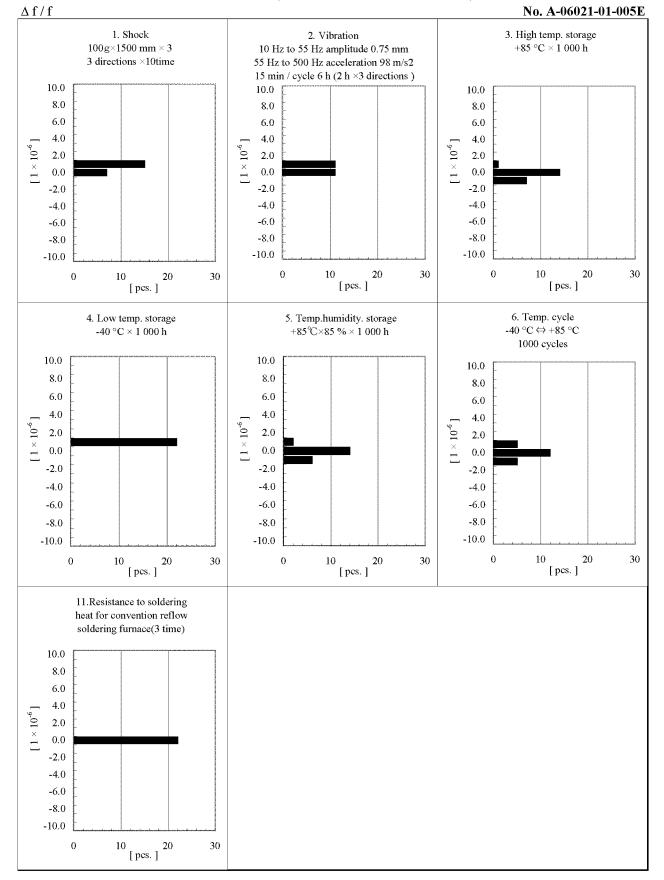
| | varuate environmentar | and mechanical characteristics by the following | g lest condition. No. A-ou | 021-01 | |
|-----|---------------------------------|---|---|--------|------|
| | | | VALUE *1 *2 | TEST | FAIL |
| No. | ITEM | TEST CONDITIONS | $\Delta f / f$ | Qty | Qty |
| | | | $[1 \times 10^{-6}]$ | [n] | [n] |
| 1 | Shock | 100g dummy Jig(ETC Standerd) drop from 1500mm hight on Concrete 3 directions 10 time | (2) ± 2 | 22 | 0 |
| 2 | Vibration | 10 Hz to 55 Hz amplitude 0.75 mm 55 Hz to 500 Hz acceleration 98 m/s ² 10 Hz => 500 Hz => 10 Hz 15 min / cycle 6 h (2 h × 3 directions) | (2) ± 1 | 22 | 0 |
| 3 | High temperature storage | +85°C × 1 000 h | (1) ± 2 | 22 | 0 |
| 4 | Low temperature storage | -40 °C × 1 000 h | (1) ± 2 | 22 | 0 |
| 5 | Temperature humidity storage | +85 °C × 85 %RH × 1 000 h | (1) ± 2 | 22 | 0 |
| 6 | Temperature cycle | -40 °C <=> +85 °C 30 min at each temp. 1000 cycles | (1) ± 2 | 22 | 0 |
| 7 | Sealing | For He leak detector | $1 \times 10^{-9} Pa \cdot m^3/s$ Max | 22 | 0 |
| 8 | Shear | 10 N press for 10 s ± 1 s Ref. IEC 60068-2-21 | No peeling - off at a solder part | 11 | 0 |
| 9 | Pull - off | 10 N press for 10 s ± 1 s Ref. IEC 60068-2-21 | No peeling - off at a solder part | 11 | 0 |
| 10 | Solderability | Dip termination into solder bath at +235 °C ± 5 °C for 5 s (Using Rosin Flux) | Termination must be 95% covered with fresh solder | 11 | 0 |
| 11 | Resistance to soldering heat | For cinvention reflow soldering furnace (3 time) | ± 1 | 22 | 0 |

Notes

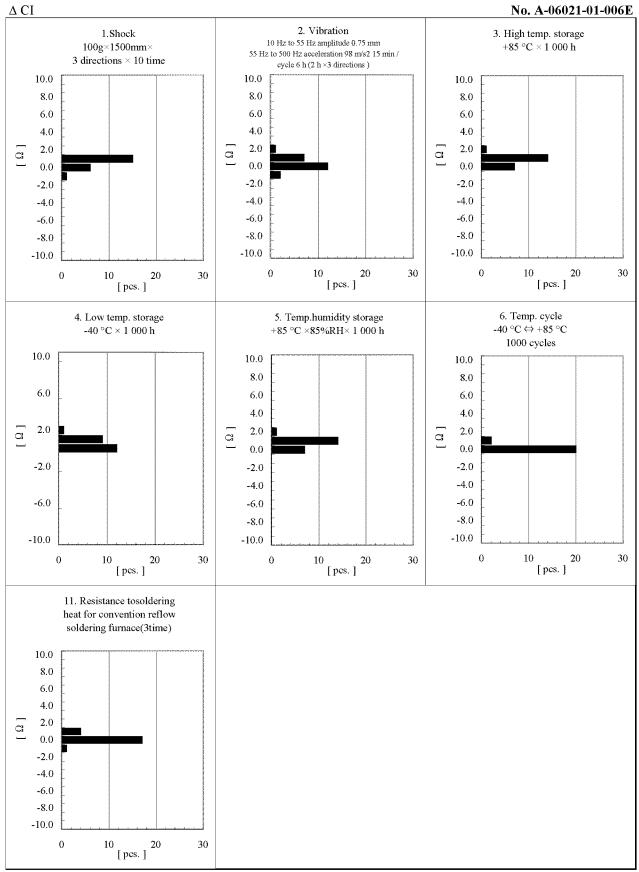
1. Item No.1 to No.10 resistance at before above tests should be less than $\pm 20\%$ or less then $\pm 10 \Omega$.

- 2. *1 Each test done independently.
- 3. *2 Measuring 2h to 24h later leaving in room temperature after each test.
 - (1) Measuring 24h later leaving in room temperature after each test.
 - (2) Measuring 2h later leaving in room temperature after each test.





Qualification Data



Product Name : TSX-3225 (16MHz \leq f0 < 40MHz)



ATTN : YF INTERNATIONAL LIMITED

Quality and reliability data

No.ST12-618 Mar., 27, 2013 SEIKO EPSON CORP. TD • CS QUALITY ASSURANCE DEPARTMENT

MODEL:TSX-3225

1.Machine Model

JEDEC JESD22-A115-A $(C=200 \ pF \ ; \ R=0 \ \Omega \) \qquad :>\pm 100 \ Volt$

2.Human Body Model

JESD22-A114D $(C = 100 \ pF \ ; R = 1 \ 500 \Omega \) ~~:> \pm 500 \ Volt$

Criterion: Frequency change rate exceeded $\pm 2 \times 10^{-6}$